·		Attorney's Docket No. 12732-182001	Application No. 10/724,872	OIPE
Information Disclosure Statement by Applicant		Applicant Yu Yamazaki et al.		MAR 0 1 2005
(Use several s	heets if necessary)	Filing Date December 2, 2003	Group Art Unit 2815	THE STATE OF THE SERVICE

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Examiner Signature	JOJEPHNEUYEN.	Date Considered	428/05
EXAMINER: Initials of next communication to	itation considered. Draw line through citation if no applicant.	ot in conformance and no	t considered. Include copy of this form with
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Attorney's Docket No. 12732-182001

Application No. 10/724,872

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Applicant

Yu Yamazaki et al.

Group Art Unit

(37 CFR §1.98(b))

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	AG	JP 08-152619	11 JUNE 1996	JAPAN			Abstract		
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Attorney's Docket No. 12732-182001

Application No. 10/724,872

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JN	AQ	Exhibition of Active Matrix Type Organic EL Display at "13 th Flat Panel Display Manufacturing / Technology Expo & Conference" by ELDis Group (in Japanese with full translation); July 2, 2003				
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